

Search Notes

Application/Control No.

10/780,579

Examiner

Leith A. Al-Nazer

Applicant(s)/Patent under
Reexamination

ONOZAWA ET AL.

Art Unit

2821

SEARCHED

Class	Subclass	Date	Examiner
315	169.1- 169.4	7/24/2005	LA
345	55, 60	7/24/2005	LA
345	204	7/24/2005	LA

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search (see attached printout)	7/24/2005	LA